Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10552709	HATAKEYAMA ET AL.
Examiner	Art Unit
HENG M CHAN	4181

SEARCHED					
Class	Subclass	Date	Examiner		
423	445B, 500, DIG39, DIG40	2/18/2009	HMC		
427	487,488,533,569,903	2/18/2009	HMC		
428	832.4, 835, 835.1	2/18/2009	HMC		
422	186, 186.04	2/18/2009	HMC		
977	734, 740, 843, 844, 847	2/18/2009	HMC		

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST databases:USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM-TDB, FPRS	2/18/2009	HMC	
Inventors searched in Palm	2/17/2009	HMC	
Google search for background knowlege about fullerenes	2/18/2009	HMC	

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